

**Search Notes**

Application/Control No.

10/529,994

Examiner

Hau V. Phan

Applicant(s)/Patent under  
Reexamination

BOSS ET AL.

Art Unit

3618

**SEARCHED**

Class	Subclass	Date	Examiner
180	65.1 65.2 65.3 65.4	5/23/2007	HP
	65.5		
	65.6		
	60		
	242		
	243		
	249		
475	149	5/23/2007	HP
	6		
	5		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR